PATENT NUMBER and ISSUE DATE

## U.S. UTILITY Patent Application

	APPL NUM 10003258	FILING DATE 12/06/2001	CLASS 324	SUBCLASS	GAU 2858		EXAMINER	
	**APPLICANT	S: Ohmina	mi Nobuy	<sup>/uki;</sup> <b>7</b> /9	·	HAV	MDAN	W
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1	35 USC 119 conditions met  Verifie 3 and Acknowledgett Examiners's initials  TITLE: Apparatus and method for analyzing capacitance of insulator							
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NOTICE OF ALL	OWANCE MAILED		CLAIMS ALLOWED				
<i>*</i> 's /		Assistant Examiner	Total Chims	Print Claim for 7 O.G			
ISS	SUE FEE		DRAWING?				
Amount Due	Date Paid	:	Sheets Drwg.	Figs.Drwg. Print Fig.			
<del></del>		Primary Examiner	Application Examiner				
Гπ≡	RMINAL	PREPARED FOR ISSUE					
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